

# MOS FIELD EFFECT TRANSISTOR 2SJ604

# SWITCHING P-CHANNEL POWER MOS FET

#### **DESCRIPTION**

The 2SJ604 is P-channel MOS Field Effect Transistor designed for solenoid, motor and lamp driver.

#### **FEATURES**

• Super low on-state resistance:

 $R_{DS(on)1} = 30 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -10 \text{ V, Ip} = -23 \text{ A)}$ 

- $R_{DS(on)2} = 43 \text{ m}\Omega$  MAX. (Vgs = -4.0 V, ID = -23 A)
- Low input capacitance:

 $C_{iss} = 3300 \text{ pF TYP.} (V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V})$ 

Built-in gate protection diode

#### **ORDERING INFORMATION**

PART NUMBER	PACKAGE
2SJ604	TO-220AB
2SJ604-S	TO-262
2SJ604-ZJ	TO-263
2SJ604-Z	TO-220SMD Note

**Note** TO-220SMD package is produced only in Japan

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	-60	V
Gate to Source Voltage (Vps = 0 V)	Vgss	∓20	V
Drain Current (DC) (Tc = 25°C)	I <sub>D(DC)</sub>	∓45	Α
Drain Current (pulse) Note1	ID(pulse)	∓120	Α
Total Power Dissipation (Tc = 25°C)	Рт	70	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	Рт	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	-35	Α
Single Avalanche Energy Note2	Eas	123	mJ

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%

2. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = -30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> =  $-20 \rightarrow 0$  V

(TO-220AB)



(TO-262)



(TO-263, TO-220SMD)



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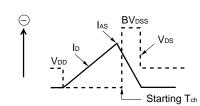


#### **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

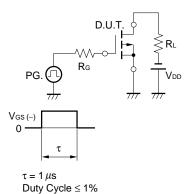
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ipss	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V			-10	μΑ
Gate Leakage Current	Igss	V <sub>G</sub> S = ∓20 V, V <sub>D</sub> S = 0 V			∓10	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1 mA	-1.5	-2.0	-2.5	V
Forward Transfer Admittance	<b>y</b> fs	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -23 A	20	41		S
Drain to Source On-state Resistance	RDS(on)1	V <sub>G</sub> S = -10 V, I <sub>D</sub> = -23 A		23	30	mΩ
	RDS(on)2	V <sub>G</sub> S = -4.0 V, I <sub>D</sub> = -23 A		30	43	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = -10 V		3300		pF
Output Capacitance	Coss	V <sub>G</sub> S = 0 V		580		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		230		pF
Turn-on Delay Time	td(on)	V <sub>DD</sub> = -30 V, I <sub>D</sub> = -23 A		12		ns
Rise Time	<b>t</b> r	V <sub>G</sub> S = −10 V		11		ns
Turn-off Delay Time	td(off)	$R_G = 0 \Omega$		77		ns
Fall Time	<b>t</b> f			52		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = -48 V		63		nC
Gate to Source Charge	Qgs	V <sub>G</sub> S = -10 V		11		nC
Gate to Drain Charge	Q <sub>GD</sub>	Ib = -45 A		16		nC
Body Diode Forward Voltage	V <sub>F</sub> (S-D)	IF = 45 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 45 A, VGS = 0 V		51		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		105		nC

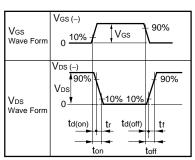
#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c} \text{D.U.T.} \\ \text{RG} = 25 \ \Omega \\ \text{PG.} \\ \text{VGS} = -20 \rightarrow 0 \ \text{V} \end{array}$

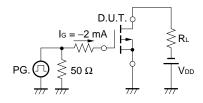


#### **TEST CIRCUIT 2 SWITCHING TIME**



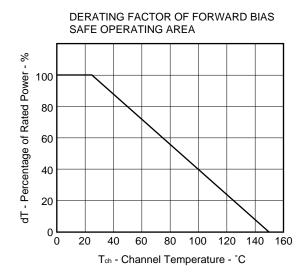


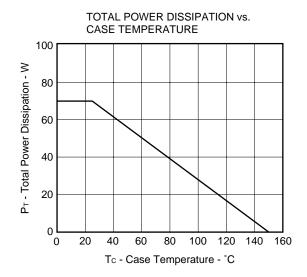
#### **TEST CIRCUIT 3 GATE CHARGE**



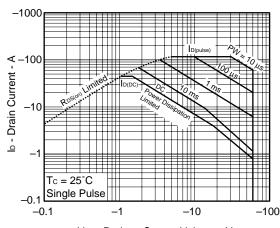


#### TYPICAL CHARACTERISTICS (TA = 25°C)

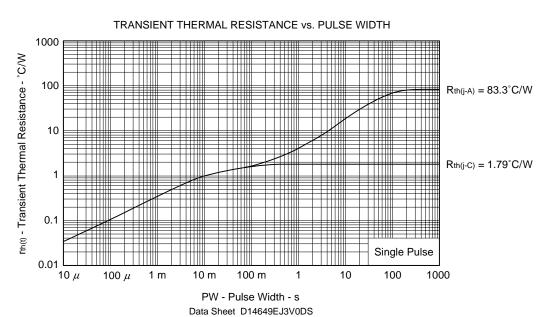




#### FORWARD BIAS SAFE OPERATING AREA

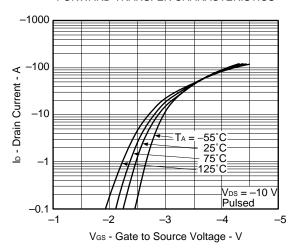


V<sub>DS</sub> - Drain to Source Voltage - V

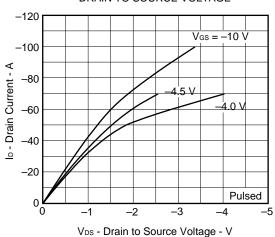


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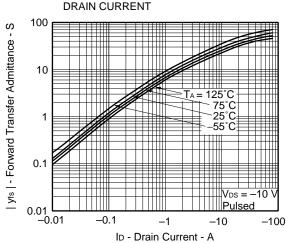
#### FORWARD TRANSFER CHARACTERISTICS



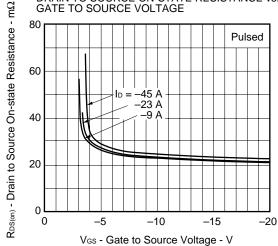
## DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



FORWARD TRANSFER ADMITTANCE vs.



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



RDS(on) - Drain to Source On-state Resistance - mΩ 80 20

0

### Pulsed 60 –4.0 V –4.5 V -10 V 40

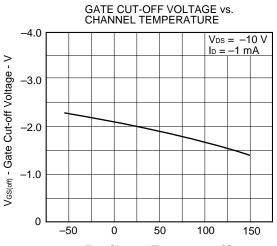
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DRAIN TO SOURCE ON-STATE

RESISTANCE vs. DRAIN CURRENT

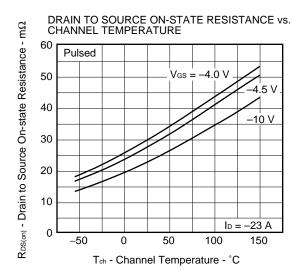
ID - Drain Current - A

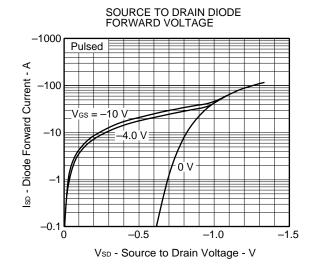
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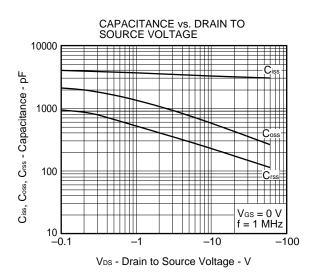


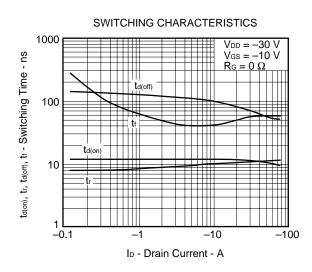
Tch - Channel Temperature - °C

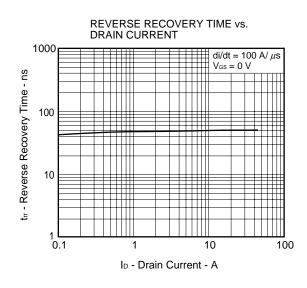
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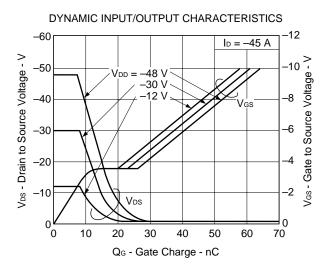




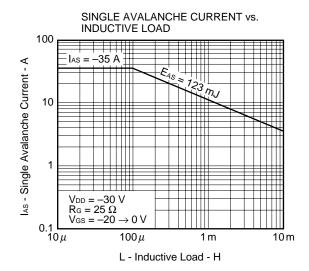


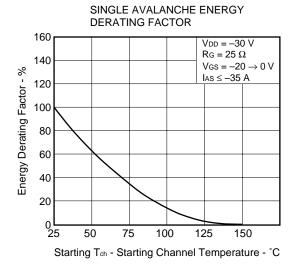






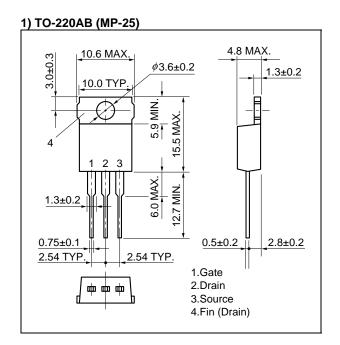
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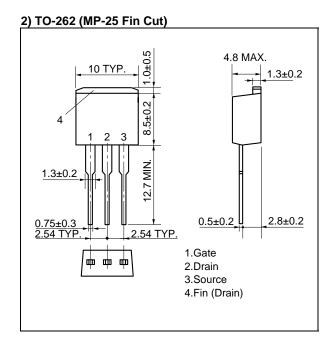


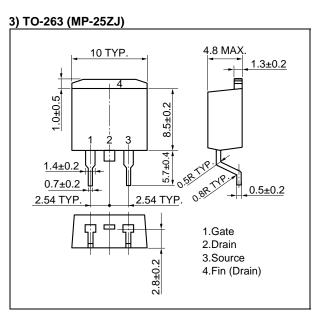


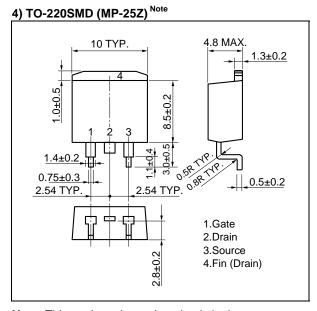


#### **★ PACKAGE DRAWINGS (Unit: mm)**



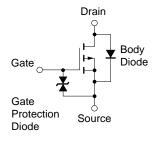






Note This package is produced only in Japan.

#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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